Application/Control No. Applicant(s)/Patent Under Reexamination BAKKER ET AL. Examiner David L. Sorkin Applicant(s)/Patent Under Reexamination BAKKER ET AL. Page 1 of 1

Notic of References Cited

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY			Classification	
	Α	US-5,651,305-A	07-1997	Bushman et al.		<u>-</u>	
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